

N Channel MOSFET

Applications:

- Adapter & Charger
- •SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

Features:

- •Low On Resistance
- Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •RoHS Compliant

Ordering Information

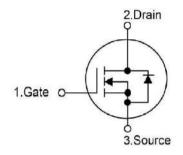
Part Number	Package	Marking
RS9N50F	TO-220F	RS9N50F



Lead Free Package and Finish

lo	Rds(ON)(Typ.)	VDSS
9A	0.65Ω	500V





Absolute Maximun Ratings Tc=25℃ unless otherwise specified

Symbol	Parameter	RS9N50F	Units
VDSS	Drain-to-Source Voltage (Note*1)	500	V
ID	Continuous Drain Current	9.0	
ID@ 100 ℃	Continuous Drain Current	4.8	Α
lом	Pulsed Drain Current (Note*2)	34.0	
PD	Power Dissipation	63	W
VGS	Gate-to-Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L=10mH VDD=50V RG=25Ω Starting TJ=25°C	320	mJ
IAS	(Note*2)	8	Α
EAR	Repetitive Avalanche Energy	40	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*}Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS9N50F	Units	Test Conditions
Rejc	Junction-to-Case	1.98	°C/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150℃.
RθJA	Junction-to-Ambient	62]	1 cubic foot chamber,free air.

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Static Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	500			٧	Vgs=0V,ID=250µA
IDSS	Drain-to-Source Leakage Current			1.0	μΑ	V_{DS} =500V,VGS=0V
looo	Gate-to-Source Forward Leakage			100	nΛ	Vgs=+30V Vps=0V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	Vgs=-30V Vps=0V

Static Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IRDS(on)	Static Drain-to-Source On-Resistance (Note*3)		0.65	0.8	Ω	V _{GS} =10V,I _D =5A
Vgs(TH)	Gate Threshold Voltage	2.0		4.0	٧	Vgs=Vds,Id=250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		25			Vps=250V
trise	Rise Time		19		nS	ID=9A
td(OFF)	Turn-OFF Delay Time		95		113	Rg=25Ω
tfall	Fall Time		24			

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1056			Vgs=0V
Coss	Output Capacitance		105	-	pF	V _{DS} =25V
Crss	Reverse Transfer Capacitance		4.4	-		f=1.0MHz
Qg	Total Gate Charge		22			Vps=400V
Qgs	Gate-to-Source Charge		5.2		nC	ID=9A VGS=10V
Qgd	Gate-to-Drain("Miller") Charge		9.3			(Note:3,4)

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Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current	-	-	9.0	Α	Integral pn-diode
Ism	Maximum Pulsed Current		-	34.0	Α	in MOSFET
VsD	Diode Forward Voltage			1.4	V	IS=9A,VGS=0V
trr	Reverse Recovery Time		320		nS	VGS=0V
Qrr	Reverse Recovery Charge	-	1.83		μC	IS=9A,di/dt=100A/μs

Notes:

Typical Feature curve

T_J = 25°C, unless otherwise noted

Figure 1. Output Characteristics (TJ = 25°C)

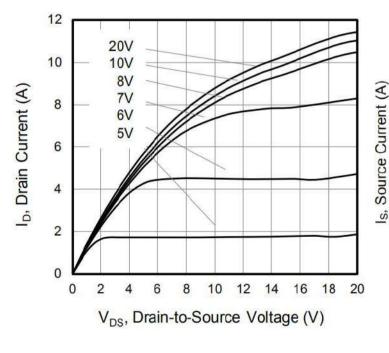
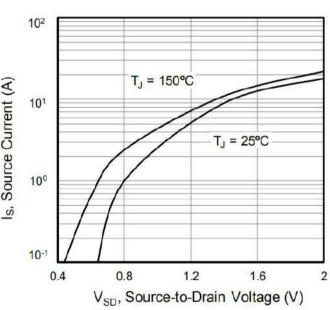


Figure 2. Body Diode Forward Voltage



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^{*1.}TJ=±25℃ to +150℃.

^{*2.}Repetitive rating; pulse width limited by maximum junction temperature.

^{*3.} Pulse width \leq 300 µs; duty cycle \leq 1%.



Figure 3. Drain Current vs. Temperature

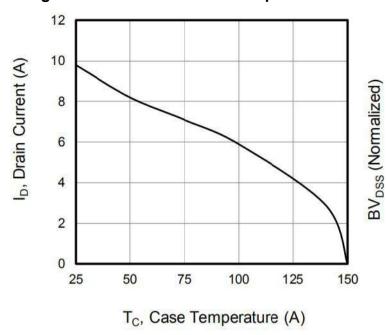


Figure 4. BVDSS Variation vs. Temperature

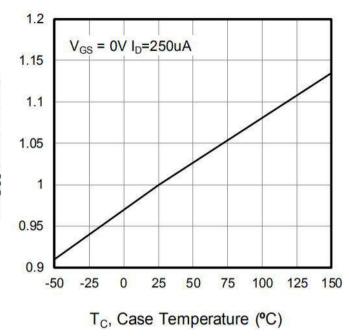


Figure 5. Transfer Characteristics

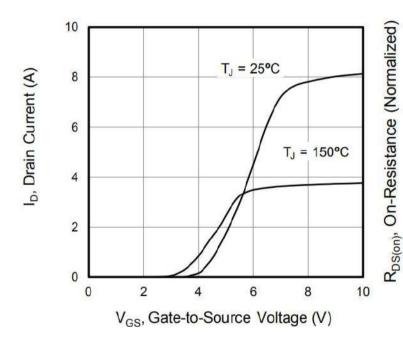
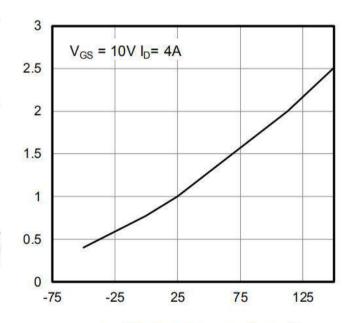


Figure 6. On-Resistance vs. Temperature



T_J, Junction Temperature (°C)

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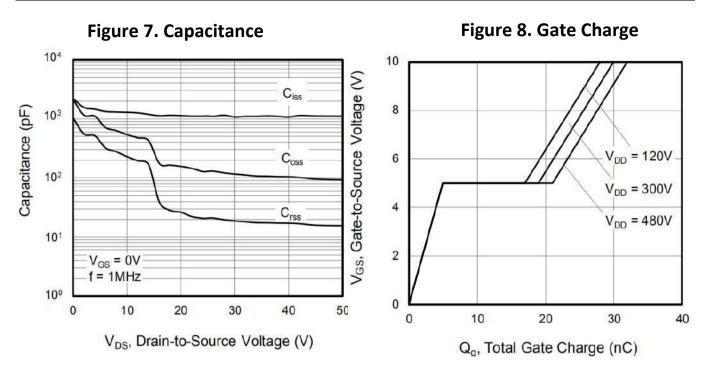
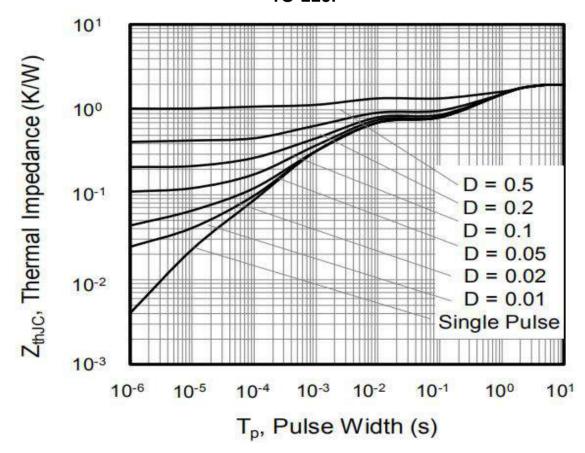


Figure 9. Transient Thermal Impedance TO-220F



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Test Circuits and Waveforms

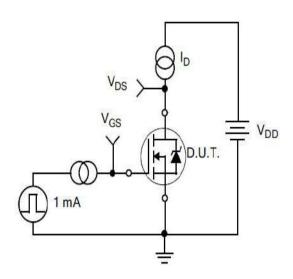


Figure 10.
Gate Charge Test Circuit

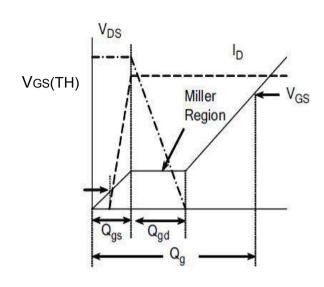


Figure 11.
Gate Charge Waveform

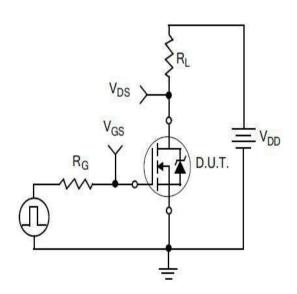


Figure12.
Resistive Switching Test Circuit

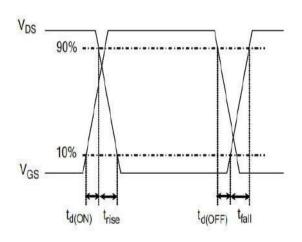


Figure 13. Resistive Switching Waveforms

Test Circuits and Waveforms

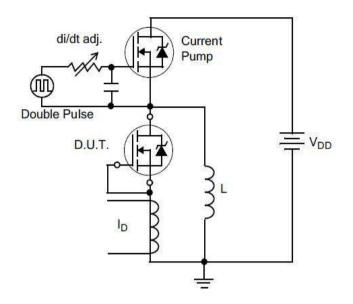


Figure 14. Diode Reverse Recovery
Test Circuit

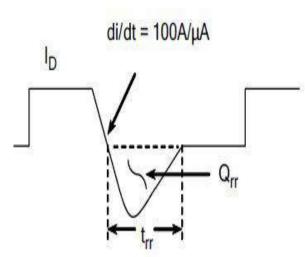


Figure 15. Diode Reverse Recovery Waveform

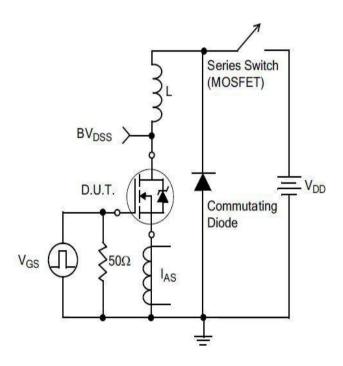


Figure 16. Unclamped Inductive Switching Test Circuit

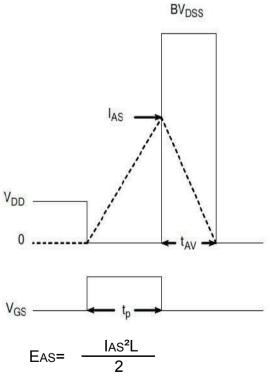
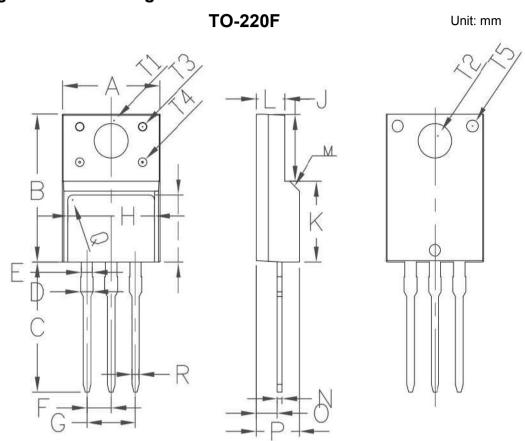


Figure 17. Unclamped Inductive Switching Waveforms



Package outline drawing



Symbol	Min	Non	Max
A	9.96	10.16	10.36
В	15.67	15.87	16.07
С	13.14	13.34	13.54
D	1.20	1.30	1.40
E		1.20	
F		2.54	
G		5.08	
Н	7.60	7.80	8.00
I	7.10	7.30	7.50
J	6.48	6.68	6.88
K	8. 99	9.19	9.39
L	2.34	2.54	2.74
M		45°	
N	0.49	0.50	0.52
0	2.15	2.35	2, 55
P	4.50	4.70	4.90
Q		0.50	
S	4°	4.5°	5°
T1		3.45	
T2		3.18	
T3		1.50	
T4		1.20	
T5		1.50	
R	0.77	0.8	0.83



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